

LMP91050 Configurable AFE for Nondispersive Infrared (NDIR) Sensing Applications

1 Features

- Programmable Gain Amplifier
- *Dark Signal* Offset Cancellation
- Supports External Filtering
- Common-Mode Generator and 8-Bit DAC
- Key Specifications
 - Programmable Gain 167 to 7986 V/V
 - Low Noise (0.1 to 10 Hz) 0.1 μ VRMS
 - Gain Drift 100 ppm/ $^{\circ}$ C (Maximum)
 - Phase Delay Drift 500 ns (Maximum)
 - Power Supply Voltage Range 2.7 to 5.5 V

2 Applications

- NDIR Sensing
- Demand Control Ventilation
- Building Monitoring
- CO₂ Cabin Control — Automotive
- Alcohol Detection — Automotive
- Industrial Safety and Security
- GHG and Freons Detection Platforms

3 Description

The LMP91050 device is a programmable integrated Sensor Analog Front End (AFE) optimized for thermopile sensors, as typically used in NDIR applications. It provides a complete signal path solution between a sensor and microcontroller that generates an output voltage proportional to the thermopile voltage. The programmability of the LMP91050 enables it to support multiple thermopile sensors with a single design as opposed to the multiple discrete solutions.

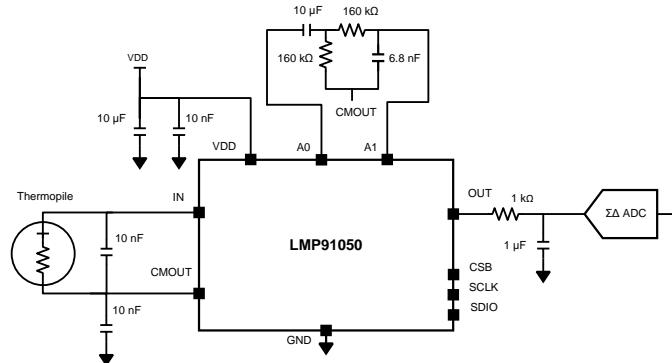
The LMP91050 features a programmable gain amplifier (PGA), *dark phase* offset cancellation, and an adjustable common-mode generator (1.15 V or 2.59 V) which increases output dynamic range. The PGA offers a low-gain range of 167 V/V to 1335 V/V plus a high-gain range of 1002 V/V to 7986 V/V which enables the user to use thermopiles with different sensitivities. The PGA is highlighted by low-gain drift (100 ppm/ $^{\circ}$ C), output offset drift (1.2 mV/ $^{\circ}$ C at G = 1002 V/V), phase delay drift (500 ns) and noise specifications (0.1 μ V_{RMS} 0.1 to 10Hz).

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LMP91050	VSSOP (10)	3.00 mm x 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Typical Application Circuit



Configurable AFE for NDIR



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (March 2013) to Revision E	Page
• Added <i>Pin Configuration and Functions</i> section, <i>ESD Ratings</i> table, <i>Feature Description</i> section, <i>Device Functional Modes</i> , <i>Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section	1

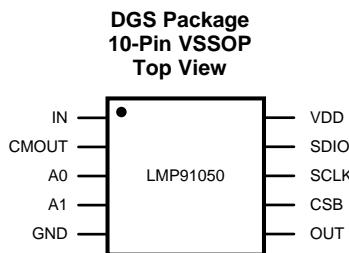
Changes from Revision C (April 2012) to Revision D	Page
• Changed layout of National Data Sheet to TI format	17

5 Description (continued)

The offset cancellation circuitry compensates for the *dark signal* by adding an equal and opposite offset to the input of the second stage, thus removing the original offset from the output signal. This offset cancellation circuitry allows optimized usage of the ADC full scale and relaxes ADC resolution requirements.

The LMP91050 allows extra signal filtering (high-pass, lowpass or bandpass) through dedicated pins A0 and A1, in order to remove out of band noise. The user can program through the on board SPI interface. Available in a small form factor 10-pin package, the LMP91050 operates from -40 to 105°C .

6 Pin Configuration and Functions



Pin Functions

PIN		TYPE	DESCRIPTION
NO.	NAME		
1	IN	Analog Input	Signal Input
2	CMOUT	Analog Output	Common-Mode Voltage Output
3	A0	Analog Output	First Stage Output
4	A1	Analog Input	Second Stage Input
5	GND	Power	Ground
6	OUT	Analog Output	Signal Output, reference to the same potential as CMOUT
7	CSB	Digital Input	Chip Select, active low
8	SCLK	Digital Input	Interface Clock
9	SDIO	Digital Input / Output	Serial Data Input / Output
10	VDD	Power	Positive Supply

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾⁽²⁾⁽³⁾

	MIN	MAX	UNIT
Supply Voltage (VDD)	-0.3	6	V
Voltage at Any Pin	-0.3	$\text{VDD} + 0.3$	V
Input Current at Any Pin		5	mA
Junction Temperature ⁽⁴⁾		150	$^{\circ}\text{C}$
Storage Temperature, T_{stg}	-65	150	$^{\circ}\text{C}$

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (3) For soldering specifications: see product folder at www.ti.com and [SNOA549](#).
- (4) The maximum power dissipation is a function of $T_{\text{J}}(\text{MAX})$, θ_{JA} , and the ambient temperature, T_{A} . The maximum allowable power dissipation at any ambient temperature is $\text{PD}_{\text{MAX}} = (T_{\text{J}}(\text{MAX}) - T_{\text{A}})/\theta_{\text{JA}}$. All numbers apply for packages soldered directly onto a PC board.

7.2 ESD Ratings

		VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2500
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1250
		Machine Model	±250

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

	MIN	MAX	UNIT
Supply Voltage	2.7	5.5	V
Junction Temperature ⁽²⁾	-40	105	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The maximum power dissipation is a function of $T_{J(MAX)}$, θ_{JA} , and the ambient temperature, T_A . The maximum allowable power dissipation at any ambient temperature is $P_{D(MAX)} = (T_{J(MAX)} - T_A) / \theta_{JA}$. All numbers apply for packages soldered directly onto a PC board.

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		LMP91050	UNIT
		DGS (VSSOP)	
		10 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	176	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

7.5 Electrical Characteristics

The following specifications apply for V_{DD} = 3.3 V, V_{CM} = 1.15 V, unless otherwise specified. All other limits apply to $T_A = T_J = +25^\circ\text{C}$.⁽¹⁾

PARAMETER	TEST CONDITIONS	MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
POWER SUPPLY					
V _{DD}	Supply voltage	2.7	3.3	5.5	V
IDD	Supply current	3.1	3.7	4.2	mA
	Power-down supply current	45	85	121	μA
OFFSET CANCELLATION (OFFSET DAC)					
Resolution		256			steps
LSB	All gains	33.8			mV
DNL		-1	2		LSB
Error	Output referred offset error, all gains	±100			mV
Offset adjust range	Output referred, all gains	0.2	V _{DD} – 0.2		V
DAC settling time		480			μs
PROGRAMMABLE GAIN AMPLIFIER (PGA) 1ST STAGE, $R_L = 10\text{ k}\Omega$, $C_L = 15\text{ pF}$					
IBIAS	Bias current	5			
	$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$		200		pA

(1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J = T_A$. No ensured specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where $T_J > T_A$. Absolute Maximum Ratings indicate junction temperature limits beyond which the device may be permanently degraded, either mechanically or electrically.

(2) Limits are 100% production tested at 25°C. Limits over the operating temperature range are ensured through correlations using statistical quality control (SQC) method.

(3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

Electrical Characteristics (continued)

The following specifications apply for $V_{DD} = 3.3$ V, $V_{CM} = 1.15$ V, unless otherwise specified. All other limits apply to $T_A = T_J = +25^\circ\text{C}$.⁽¹⁾

PARAMETER	TEST CONDITIONS	MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
VINMAX _HGM	Referenced to CMOUT voltage, it refers to the maximum voltage at the IN pin before clipping; It includes dark voltage of the thermopile and signal voltage.	±2	mV	±12	mV
VINMAX _LGM					
VOS	Input offset voltage		-165		µV
G_HGM	Gain high-gain mode		250		V/V
G_LGM	Gain low-gain mode		42		V/V
GE	Gain error	Both HGM and LGM		2.5%	
VOUT	Output voltage range		0.5	VDD – 0.5	V
PhDly	Phase delay	1-mV input step signal, HGM, V_{OUT} measured at $V_{DD}/2$		6	µs
TCPPhDly	Phase delay variation with temperature	1-mV input step signal, HGM, V_{OUT} measured at $V_{DD}/2$,		416	ns
SSBW	Small signal bandwidth	$V_{IN} = 1\text{mVpp}$, Gain = 250 V/V		18	kHz
Cin	Input capacitance			100	pF
PROGRAMMABLE GAIN AMPLIFIER (PGA) 2ND STAGE, $R_S = 1\text{k}\Omega$, $C_L = 1\text{ }\mu\text{F}$					
VINMAX	Max input signal	GAIN = 4 V/V		1.65	V
VINMIN	Min input signal			0.82	V
G	Gain	Programmable in 4 steps	4	32	V/V
GE	Gain error	Any gain		2.5	%
VOUT	Output voltage range		0.2	VDD – 0.2	V
PhDly	Phase delay	100-mV input sine 35-kHz signal, Gain = 8, V_{OUT} measured at 1.65 V, $R_L = 10\text{k}\Omega$		1	µs
TCPPhDly	Phase delay variation with temperature	250-mV input step signal, Gain = 8, V_{OUT} measured at $V_{DD}/2$		84	ns
SSBW	Small signal bandwidth	Gain = 32 V/V		360	kHz
Cin	Input capacitance			5	pF
CLOAD, OUT	OUT pin load capacitance	Series RC		1	µF
RLOAD, OUT	OUT pin load resistance	Series RC		1	kΩ
COMBINED AMPLIFIER CHAIN SPECIFICATION					
en	Input-referred noise density	Combination of both current and voltage noise, with a 86kΩ source impedance at 5Hz, Gain = 7986		30	nV/√Hz
	Input-referred integrated noise	Combination of both current and voltage noise, with a 86kΩ source impedance 0.1Hz to 10Hz, Gain = 7986	0.1	0.12 ⁽⁴⁾	µVrms
G	Gain	PGA1 GAIN = 42, PGA2 GAIN = 4		167	V/V
		PGA1 GAIN = 42, PGA2 GAIN = 8		335	
		PGA1 GAIN = 42, PGA2 GAIN = 16		669	
		PGA1 GAIN = 42, PGA2 GAIN = 32		1335	
		PGA1 GAIN = 250, PGA2 GAIN = 4		1002	
		PGA1 GAIN = 250, PGA2 GAIN = 8		2004	
		PGA1 GAIN = 250, PGA2 GAIN = 16		4003	
		PGA1 GAIN = 250, PGA2 GAIN = 32		7986	
GE	Gain error	Any gain		5%	

(4) Specified by design and characterization. Not tested on shipped production material.

Electrical Characteristics (continued)

The following specifications apply for $V_{DD} = 3.3$ V, $V_{CM} = 1.15$ V, unless otherwise specified. All other limits apply to $T_A = T_J = +25^\circ\text{C}$.⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
TCCGE	Gain temp coefficient ⁽⁵⁾	$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$			100	ppm/ $^\circ\text{C}$
PSRR	Power supply rejection ratio	DC, 3-V to 3.6-V supply, gain = 1002 V/V	90	110		dB
PhDly	Phase delay	1-mV input step signal, Gain = 1002, V_{OUT} measured at $V_{DD}/2$		9		μs
TCPPhDly	Phase delay variation with temperature ⁽⁶⁾	1-mV input step signal, Gain=1002, V_{OUT} measured at $V_{DD}/2$, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$			500	ns
TCVOS	Output offset voltage temperature drift ⁽⁵⁾	Gain = 167 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-0.525	0.525		mV/ $^\circ\text{C}$
		Gain = 335 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-0.6	0.6		
		Gain = 669 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-0.9	0.9		
		Gain = 1335 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-1.5	1.5		
		Gain = 1002 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-1.2	1.2		
		Gain = 2004 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-1.9	1.9		
		Gain = 4003 V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-3.7	3.7		
		Gain = 7986V/V, $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-7.1	7.1		
COMMON-MODE GENERATOR						
VCM	Common-mode voltage	Programmable, see Common-Mode Generation	1.15 or 2.59			V
	VCM accuracy		2%			
CLOAD	CMOut load capacitance		10			nF

(5) TCCGE and TCVOS are calculated by taking the largest slope between -40°C and 25°C linear interpolation and 25°C and 85°C linear interpolation.

(6) TCPPhDly is largest change in phase delay between -40°C and 25°C measurements and 25°C and 85°C measurements.

7.6 SPI Interface

The following specifications apply for $V_{DD} = 3.3$ V, $V_{CM} = 1.15$ V, $C_L = 15$ pF, unless otherwise specified. All other limits apply to $T_A = T_J = +25^\circ\text{C}$.⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
V_{IH}	Logic input high		0.7 $\times V_{DD}$			V
V_{IL}	Logic input low			0.8		V
V_{OH}	Logic output high		2.6			V
V_{OL}	Logic output low			0.4		V
IIH/IIL	Input digital leakage current		-100	100		nA
		$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	-200	200		

- Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J = T_A$. No ensured specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where $T_J > T_A$. Absolute Maximum Ratings indicate junction temperature limits beyond which the device may be permanently degraded, either mechanically or electrically.
- Limits are 100% production tested at 25°C . Limits over the operating temperature range are ensured through correlations using statistical quality control (SQC) method.
- Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

7.7 Timing Characteristics

The following specifications apply for $V_{DD} = 3.3$ V, $V_{CM} = 1.15$ V, $C_L = 15$ pF, unless otherwise specified. All other limits apply to $T_A = T_J = +25^\circ\text{C}$.⁽¹⁾

- Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J = T_A$. No ensured specification of parametric performance is indicated in the electrical tables under conditions of internal self-heating where $T_J > T_A$. Absolute Maximum Ratings indicate junction temperature limits beyond which the device may be permanently degraded, either mechanically or electrically.

Timing Characteristics (continued)

The following specifications apply for $V_{DD} = 3.3$ V, $V_{CM} = 1.15$ V, $C_L = 15$ pF, unless otherwise specified. All other limits apply to $T_A = T_J = +25^\circ\text{C}$.⁽¹⁾

PARAMETER	TEST CONDITIONS	MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
t_{WU}	Wake-up time		1		ms
f_{SCLK}	Serial clock frequency			10	MHz
t_{PH}	SCLK pulse width high		0.4 / f_{SCLK}		ns
t_{PL}	SCLK pulse width low		0.4 / f_{SCLK}		ns
t_{CSS}	CSB set-up time		10		ns
t_{CSH}	CSB hold time		10		ns
t_{SU}	SDI set-up time prior to rise edge of SCLK		10		ns
t_{SH}	SDI hold time prior to rise edge of SCLK		10		ns
t_{DOD1}	SDO disable time after rise edge of CSB			45	ns
t_{DOD2}	SDO disable time after 16 th rise edge of SCLK			45	ns
t_{DOE}	SDO enable time from the fall edge of 8 th SCLK			35	ns
t_{DOA}	SDO access time after the fall edge of SCLK			35	ns
t_{DOH}	SDO hold time after the fall edge of SCLK		5		ns
t_{DOR}	SDO rise time			5	ns
t_{DOF}	SDO fall time			5	ns

(2) Limits are 100% production tested at 25°C . Limits over the operating temperature range are ensured through correlations using statistical quality control (SQC) method.

(3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration. The typical values are not tested and are not ensured on shipped production material.

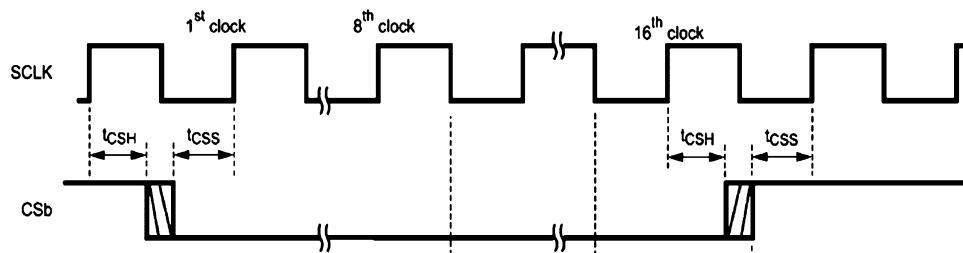


Figure 1. SPI Timing Diagram

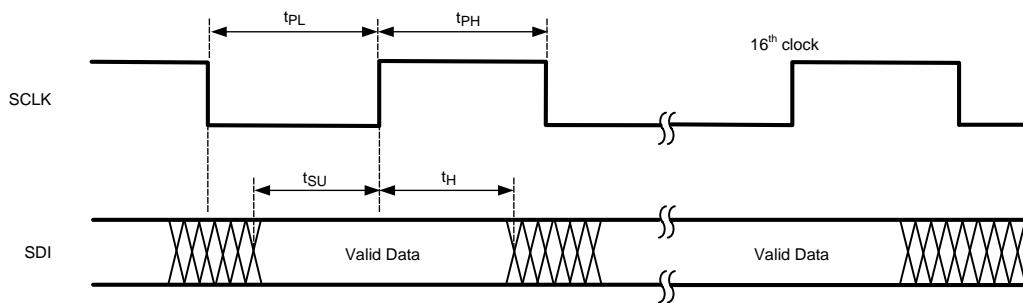


Figure 2. SPI Set-Up Hold Time

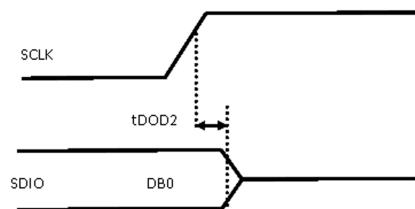


Figure 3. SDO Disable Time After 16th Rise Edge of SCLK

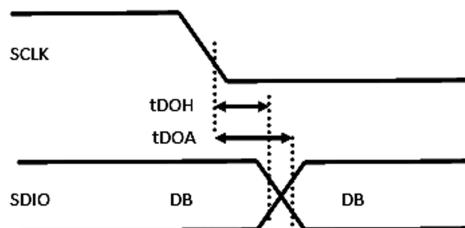


Figure 4. SDO Access Time (t_{DOA}) and SDO Hold Time (t_{DOH}) After the Fall Edge of SCLK

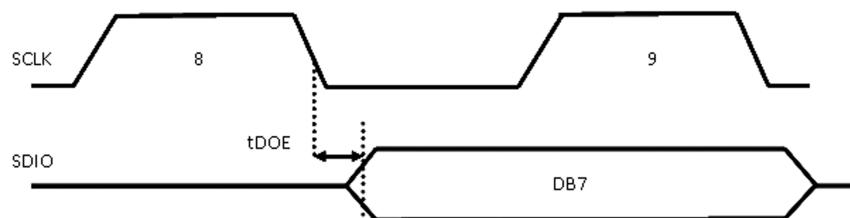


Figure 5. SDO Enable Time from the Fall Edge of 8th SCLK

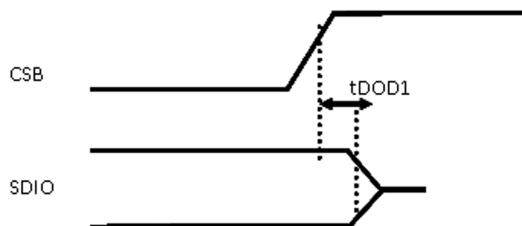


Figure 6. SDO Disable Time after Rise Edge of CSB



Figure 7. SDO Rise and Fall Times

7.8 Typical Characteristics

VDD = +3.3 V, VCM = 1.15 V, and T_A = 25°C unless otherwise noted

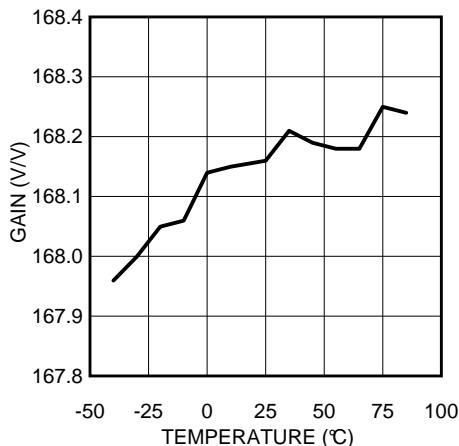


Figure 8. Gain = 167 V/V vs. Temperature

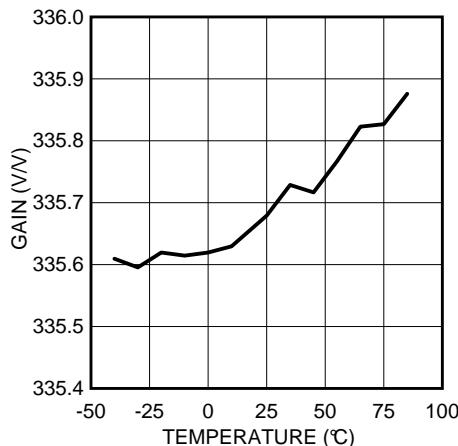


Figure 9. Gain = 335 V/V vs. Temperature

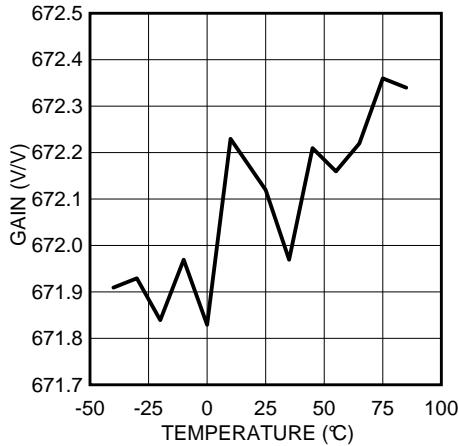


Figure 10. Gain = 669 V/V vs. Temperature

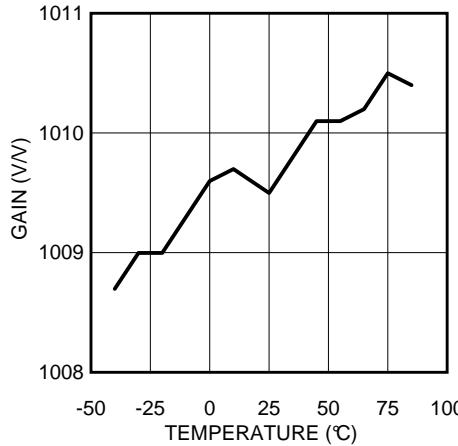


Figure 11. Gain = 1002 V/V vs. Temperature

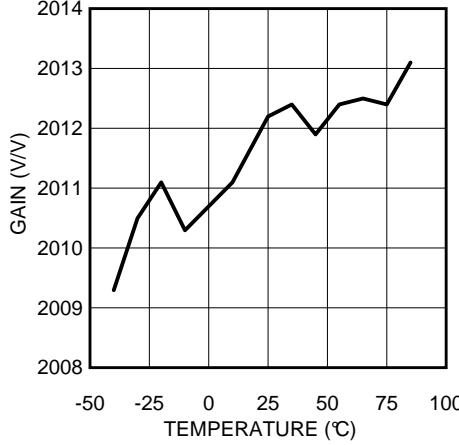


Figure 12. Gain = 2004 V/V vs. Temperature

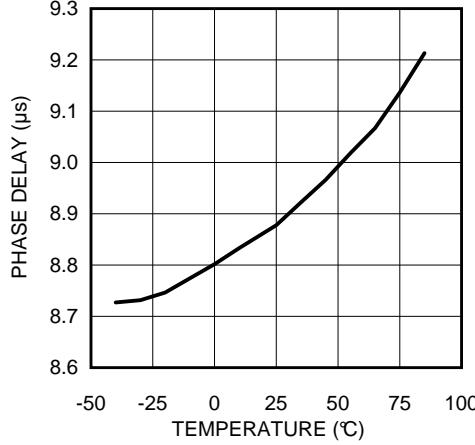
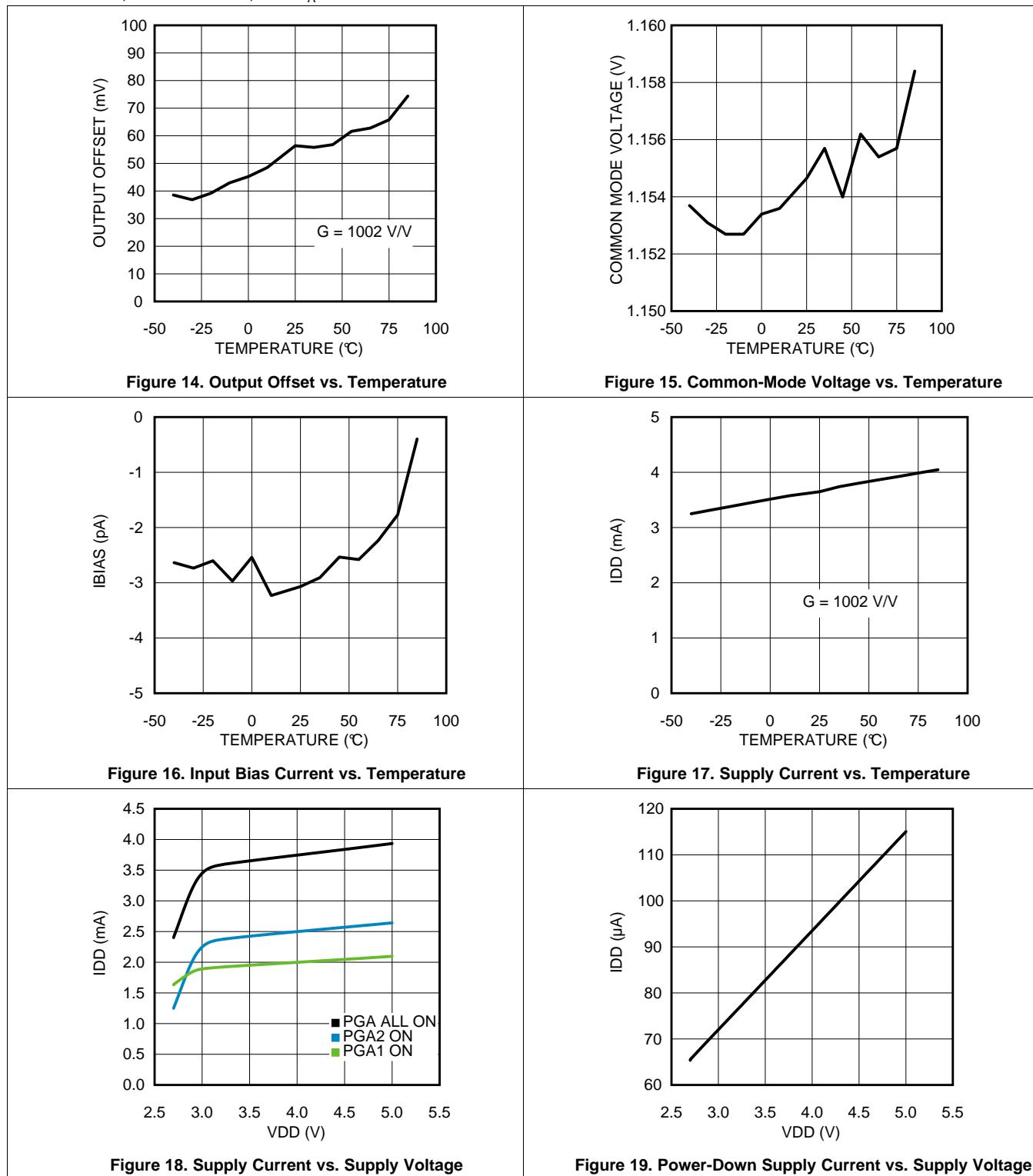


Figure 13. Phase Delay vs. Temperature

Typical Characteristics (continued)

VDD = +3.3 V, VCM = 1.15 V, and T_A = 25°C unless otherwise noted



Typical Characteristics (continued)

V_{DD} = +3.3 V, V_{CM} = 1.15 V, and T_A = 25°C unless otherwise noted

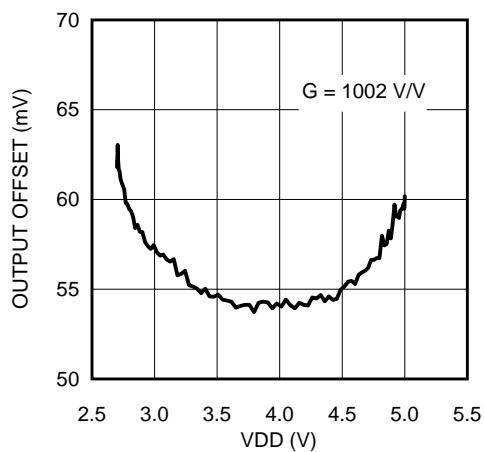


Figure 20. Output Offset vs. Supply Voltage

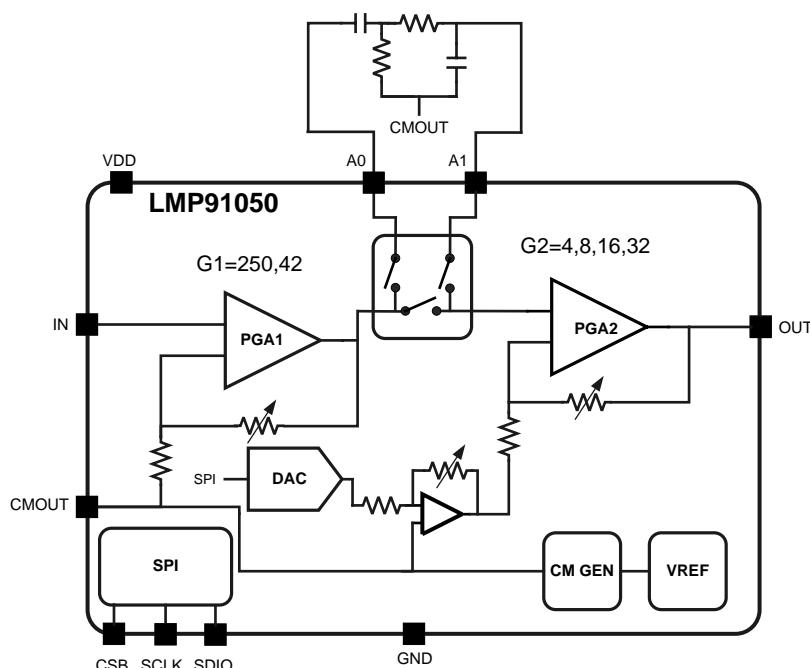
8 Detailed Description

8.1 Overview

The input channel of the LMP91050 features two programmable gain stages that give the user flexibility in optimizing the system gain. Access to the inter-stage connection between the gain blocks also allows the inclusion of appropriate filtering if needed. The internal DAC allows the DC offset of the output voltage to be adjusted independently of the common-mode voltage supplied to the sensor, enabling the sampled signal to be centered within the ADC full-scale input range.

The following paragraphs discuss the LMP91050's features in more detail.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Programmable Gain Amplifier

The LMP91050 offers two programmable gain modes (low or high) with four programmable gain settings each. The purpose of the gain mode is to enable thermopiles with larger dark voltage levels. All gain settings are accessible through bits GAIN1 and GAIN2[1:0]. The low-gain mode has a range of 167 V/V to 1335 V/V while the high-gain mode has a range of 1002 V/V to 7986 V/V. The PGA is referenced to the internally generated VCM. Input signal, referenced to this VCM voltage, should be within ± 2 mV (see VINMAX_HGM specification) in high-gain mode. In the low gain mode the first stage will provide a gain of 42 V/V instead of 250 V/V, thus allowing a larger maximum input signal up to ± 12 mV (VINMAX_LGM).

Table 1. Gain Modes

BIT SYMBOL	GAIN
GAIN1	0: 250 (default)
	1: 42

Feature Description (continued)

Table 1. Gain Modes (continued)

BIT SYMBOL	GAIN
GAIN2 [1:0]	00: 4 (default)
	01: 8
	10: 16
	11: 32

8.3.2 External Filter

The LMP91050 offers two different measurement modes selectable through EXT_FILT bit. EXT_FILT bit is present in the Device configuration register and is programmable through SPI.

Table 2. Measurement Modes

BIT SYMBOL	MEASUREMENT MODE
EXT_FILT	0: The signal from the thermopile is being processed by the internal PGAs, without additional external decoupling or filtering (default).
	1: The signal from the thermopile is being processed by the first internal PGA and fed to the A0 pin. An external low pass, high pass or band pass filter can be connected through pins A0, A1.

An external filter can be applied when EXT_FILT = 1. A typical band pass filter is shown in the picture below. Resistor and capacitor can be connected to the CMOUT pin of the LMP91050 as shown. Discrete component values have been added for reference.

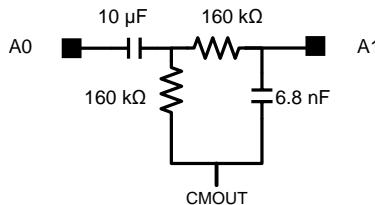


Figure 21. Typical Bandpass Filter

8.3.3 Offset Adjust

Procedure of the offset adjust is to first measure the *dark signal*, program the DAC to adjust, and then measure in a second cycle the residual of the dark signal for further signal manipulation within the μ C. The signal source is expected to have an offset component (dark signal) larger than the actual signal. During the *dark phase*, the time when no light is detected by the sensor, the μ C can program LMP91050 internal DAC to compensate for a measured offset. A low output offset voltage temperature drift (TCVOS) ensures system accuracy over temperature. See [Figure 22](#) below which plots the maximum TCVOS allowed over a given temperature drift in order to achieve n bit system accuracy.

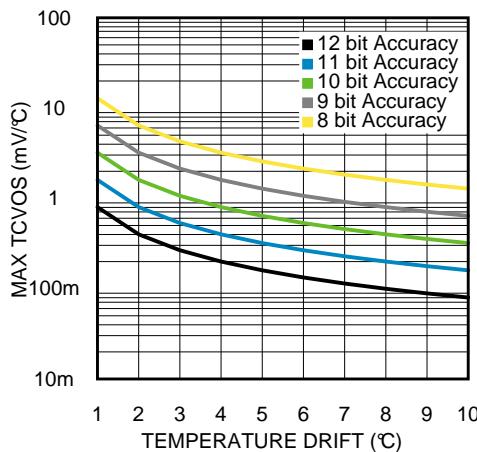


Figure 22. System Accuracy vs. TCVOS and Temperature Drift

8.3.4 Common-Mode Generation

As the offset of the sensor is bipolar, there is a need to supply a VCM to the sensor. This can be programmed as 1.15 V or 2.59 V (approximately mid rail of 3.3-V or 5-V supply). TI does not recommend to use 2.59-V VCM with a 3.3-V supply

8.3.5 CSB

Chip Select is a active-low signal. CSB needs to be asserted throughout a transaction. That is, CSB should not pulse between the Instruction Byte and the Data Byte of a single transaction.

NOTE

CSB de-assertion always terminates an on-going transaction, if it is not already complete. Likewise, CSB assertion will always bring the device into a state, ready for next transaction, regardless of the termination status of a previous transaction.

CSB may be permanently tied low for a 2-wire SPI communication protocol.

8.3.5.1 SCLK

SCLK can idle High or Low for a write transaction. However, for a READ transaction, SCLK must idle high. SCLK features a Schmitt-triggered input and although it has hysterisis, TI recommends to keep SCLK as clean as possible to prevent glitches from inadvertently spoiling the SPI frame.

8.4 Device Functional Modes

To read the registers of the LMP91050, the SDIO mode enable register must be written using a special sequence, as described in the [SDIO Mode](#) section. During the reading process, the analog OUT pin is still active, as normal. There are no other special modes for the device.

8.5 Programming

8.5.1 SPI Interface

An SPI interface is available in order to program the device parameters like PGA gain of two stages, enabling external filter, enabling power for PGAs, offset adjust and common-mode (VCM) voltage.

8.5.1.1 Interface Pins

The Serial Interface consists of SDIO (Serial Data Input / Output), SCLK (Serial Interface Clock) and CSB (Chip Select Bar). The serial interface is write-only by default. Read operations are supported after unlocking the SDIO_MODE_PASSWD. This is discussed in detail later in the document.

Programming (continued)

8.5.1.2 Communication Protocol

Communication on the SPI normally involves Write and Read transactions. Write transaction consists of single Write Command Byte, followed by single Data byte. The following figure shows the SPI Interface Protocol for write transaction.

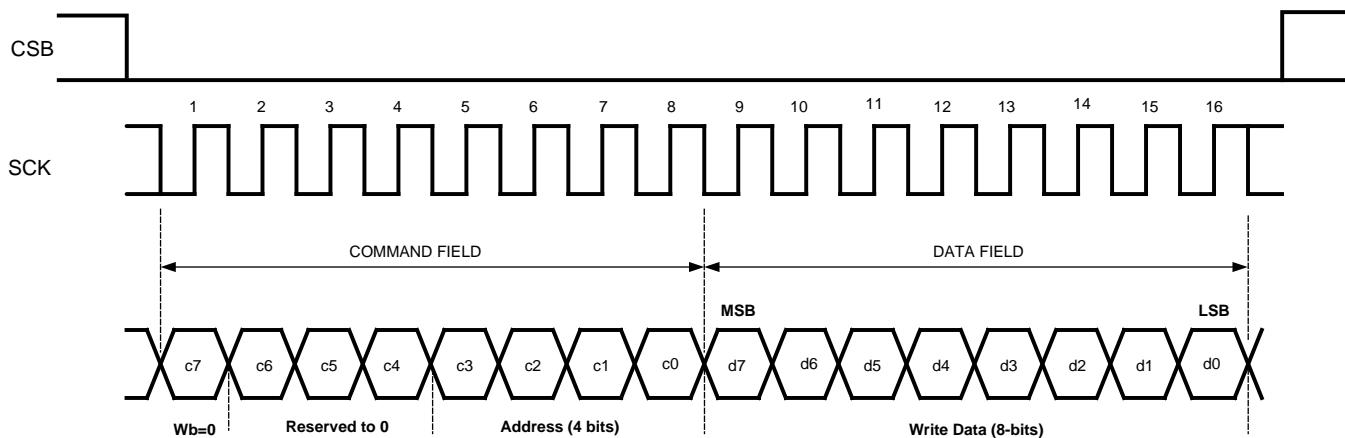
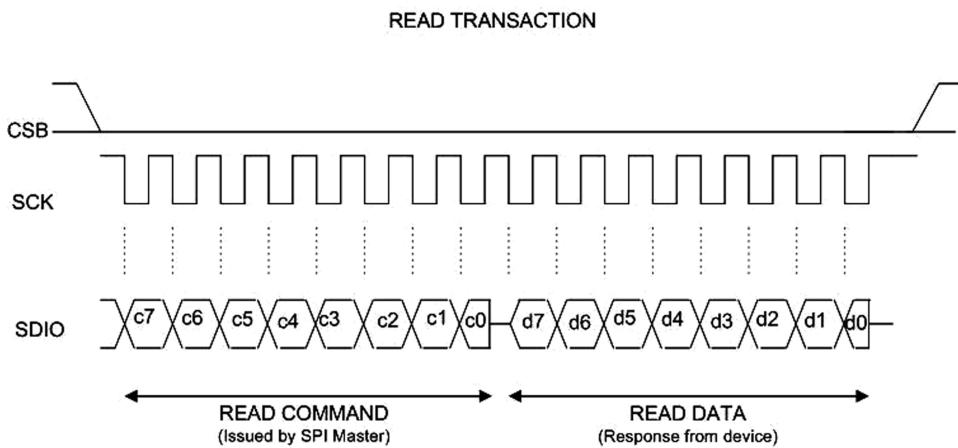


Figure 23. SPI Interface Protocol

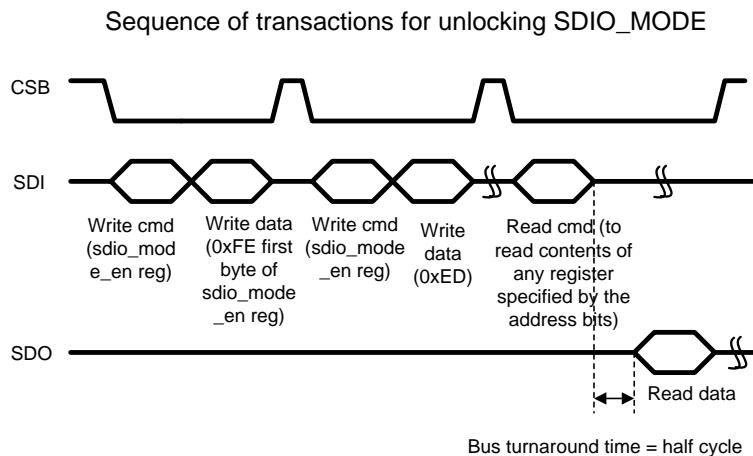
For Read transactions, user first needs to write into a SDIO mode enable register for enabling the SPI read mode. Once the device is enabled for Reading, the data is driven out on the SDIO pin during the Data field of the Read Transaction. SDIO pin is designed as a bidirectional pin for this purpose. [Figure 24](#) shows the Read transaction. The sequence of commands that need to be issued by the SPI Master to enable SPI read mode is shown in [Figure 25](#).



Note: Read command is issued by the SPI Master, who after issuing the c0 (LSB of the command byte) bit should relinquish the data line (high-Z) after meeting the hold timing(10ns) and stop SCK idling high.

Figure 24. Read Transaction

Programming (continued)



Note:

1. Once the SDIO_mode is unlocked. The user can read as many registers as long as nothing else is written to sdio_mode_en register to disturb the state of SDIO_mode
2. The separate signals SDI and SDO are given in the figure for the sake of understanding. However, only one signal SDIO exists in the design

Figure 25. Enable SDIO Mode for Reading SPI Registers

8.5.1.3 Registers Organization

Configuring the device is achieved using Write of the designated registers in the device. All the registers are organized into individually addressable byte-long registers that have a unique address. The format of the Write/Read instruction is as shown below.

Table 3. Write / Read Instruction Format

Bit[7]	Bit[6:4]	Bit[3:0]
0 : Write Instruction	Reserved to 0	Address
1 : Read Instruction		

8.6 Register Maps

This section describes the programmable registers and the associated programming sequence, if any, for the device. [Table 4](#) shows the summary listing of all the registers that are available to the user and their power-up values.

Table 4. Register Descriptions

Title	Address (Hex)	Type	Power-up/Reset Value (Hex)
Device Configuration	0x0	Read-Write	0x0
		(Read allowed in SDIO Mode)	
DAC Configuration	0x1	Read-Write	0x80
		(Read allowed in SDIO Mode)	
SDIO Mode Enable	0xF	Write-only	0x0

8.6.1 Device Configuration

Table 5. Device Configuration Register (Address 0x0)

Bit	Bit Symbol	Description
7	RESERVED	Reserved to 0.
[6:5]	EN	00: PGA1 OFF PGA2 OFF (default)
		01: PGA1 OFF, PGA2 ON
		10: PGA1 ON, PGA2 OFF
		11: PGA1 ON, PGA2 ON
4	EXT_FILT	0: PGA1 to PGA2 direct (default)
		1: PGA1 to PGA2 via external filter
3	CMN_MODE	0 : 1.15V (default)
		1 : 2.59V
[2:1]	GAIN2	00: 4 (default)
		01: 8
		10: 16
		11: 32
0	GAIN1	0: 250 (default)
		1: 42

8.6.2 DAC Configuration

The output DC level will shift according to the formula $V_{out_shift} = -33.8mV * (NDAC - 128)$.

Table 6. DAC Configuration Register (Address 0x1)

Bit	Bit Symbol	Description
[7:0]	NDAC	128 (0x80): $V_{out_shift} = -33.8mV * (128 - 128) = 0mV$ (default)

8.6.3 SDIO Mode

Write-only

Table 7. SDIO Mode Enable Register (Address 0xf)

Bit	Bit Symbol	Description
[7:0]	SDIO_MODE_EN	To enter SDIO Mode, write the successive sequence 0xFE and 0xED. Write anything other than this sequence to get out of mode.

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

Figure 26 shows a typical NDIR sensing circuit with a bandpass filter with a high frequency cutoff of approximately 100 Hz. The lowpass filter at the output has a cutoff of approximately 110 Hz.

9.2 Typical Application

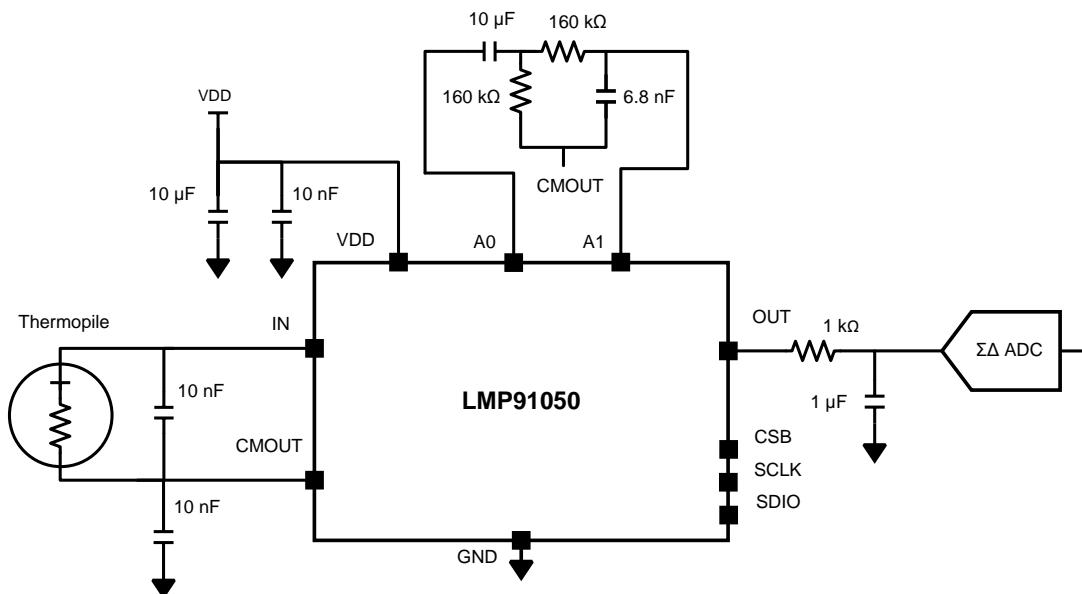


Figure 26. Typical NDIR Sensing Application Circuit

9.2.1 Design Requirements

The design requirements for using the LMP91050 in an application basically include the following:

- Determine the characteristics of the thermopile and the appropriate gain and common mode voltage that will maximize the dynamic range of the sensor. Consult the manufacturer's data sheet.
- Selecting an analog-to-digital converter that supports the needed resolution and update rate.
- Determining the bandwidth of the inter-stage low-pass filter to limit the noise imposed on the signal
- An SPI interface to a microcontroller or other logic device is required in order to configure the LMP91050.

9.2.2 Detailed Design Procedure

The basic design procedure is as follows:

- Select the appropriate inter-stage bandpass filter bandwidth. Note that the common mode voltage (CMOUT) is connected to both the thermopile and the bandpass filter, as shown in Figure 26.
- TI recommends that a lowpass filter be inserted between the OUT pin and the input to the ADC, to further reduce noise on the signal and prevent aliasing.
- Power supply bypassing as shown in figure 32 is recommended.
- Based on the thermopile characteristics, select the common-mode voltage and gain to be programmed into the LMP91050. CMOUT should be selected to center the expected dynamic range of the thermopile within the full scale range of the ADC to the best extent possible. The gain should be selected to maximize the

Typical Application (continued)

signal range at the ADC input, but should allow some headroom below full scale to prevent clipping. The gain should also compensate, if possible, for any loss due to the filters in the signal path.

- The internal DAC can be programmed to further optimize the signal range on the OUT pin. See [Offset Adjust](#) for further information.

9.2.3 Application Curves

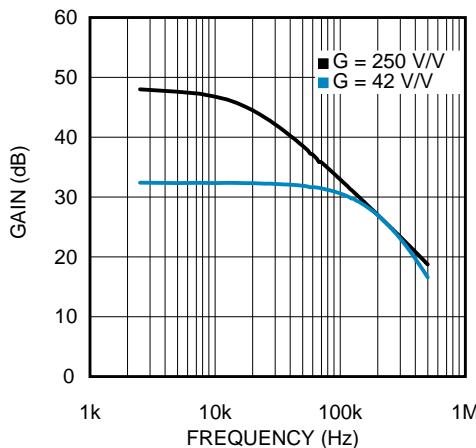


Figure 27. PGA1 Small Signal Bandwidth

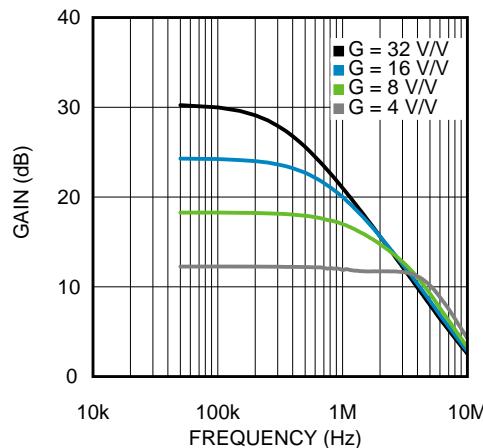


Figure 28. PGA2 Small Signal Bandwidth

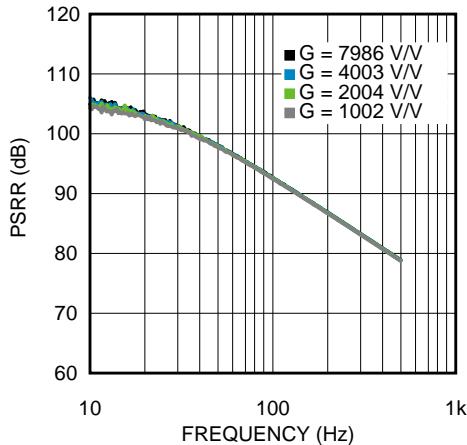


Figure 29. Power Supply Rejection Ratio vs. Frequency

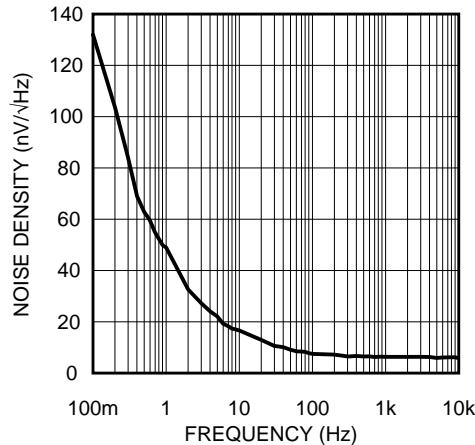


Figure 30. Input-Referred Noise Density vs. Frequency

Typical Application (continued)

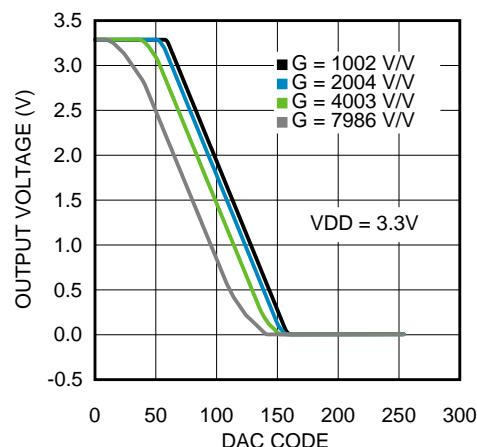


Figure 31. DAC DC Sweep With $V_{DD} = 3.3\text{ V}$

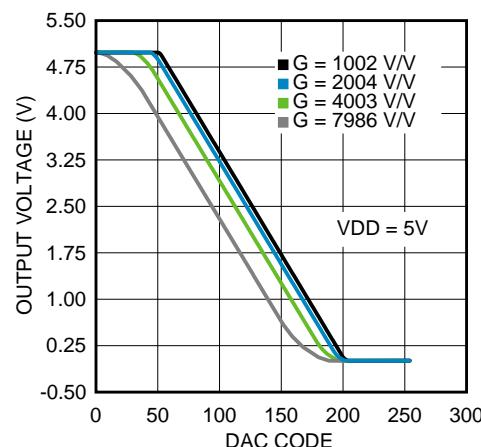


Figure 32. DAC DC Sweep With $V_{DD} = 5\text{ V}$

10 Power Supply Recommendations

Because the LMP91050 is used in a sampled data system, care must be taken to maintain power supply noise below an acceptable level, which will depend on the requirements of the application. In all cases, follow the manufacturer's design recommendations for the power conditioning device used in the system. The LMP91050 offers excellent power supply rejection over a wide range of frequencies, but adequate power supply bypassing should always be used (see [Figure 26](#)). If using a switching supply, additional filtering may be required particularly if the switcher harmonics fall within the passband of the filters used in the system. Ensure that the selected power conditioning device is capable of sourcing the current required by the LMP91050.

11 Layout

11.1 Layout Guidelines

[Figure 33](#) shows a layout example for the LMP91050. All components should be placed as close as possible to the device, especially the bypass capacitors to VDD (CBypass1 and CBypass2).

11.2 Layout Example

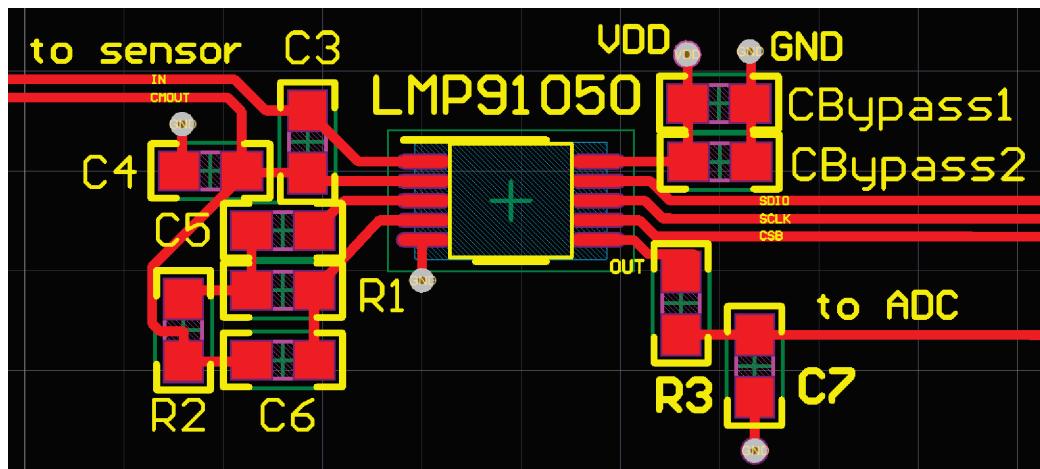


Figure 33. LMP91050 Layout Example

12 Device and Documentation Support

12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

[SLYZ022](#) — *TI Glossary.*

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMP91050MM/NOPB	ACTIVE	VSSOP	DGS	10	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 105	AN8A	Samples
LMP91050MME/NOPB	ACTIVE	VSSOP	DGS	10	250	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 105	AN8A	Samples
LMP91050MMX/NOPB	ACTIVE	VSSOP	DGS	10	3500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 105	AN8A	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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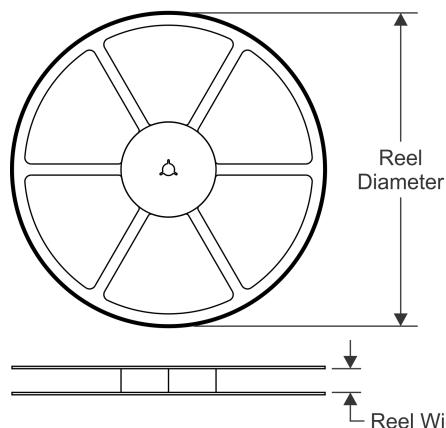
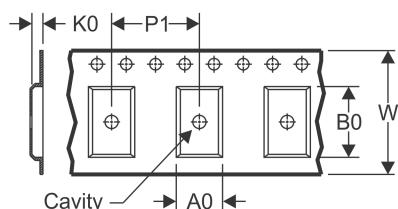


www.ti.com

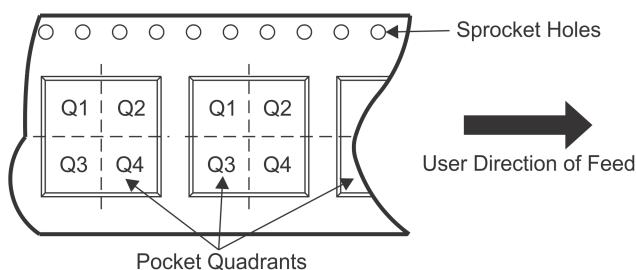
PACKAGE OPTION ADDENDUM

10-Dec-2020

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

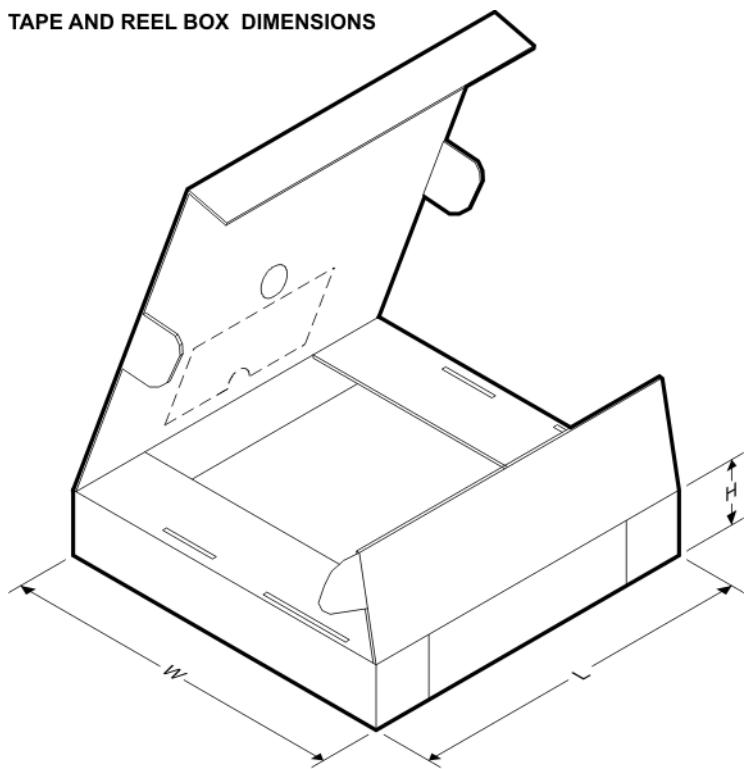
TAPE AND REEL INFORMATION
REEL DIMENSIONS

TAPE DIMENSIONS


A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMP91050MM/NOPB	VSSOP	DGS	10	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMP91050MME/NOPB	VSSOP	DGS	10	250	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMP91050MMX/NOPB	VSSOP	DGS	10	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMP91050MM/NOPB	VSSOP	DGS	10	1000	208.0	191.0	35.0
LMP91050MME/NOPB	VSSOP	DGS	10	250	208.0	191.0	35.0
LMP91050MMX/NOPB	VSSOP	DGS	10	3500	853.0	449.0	35.0

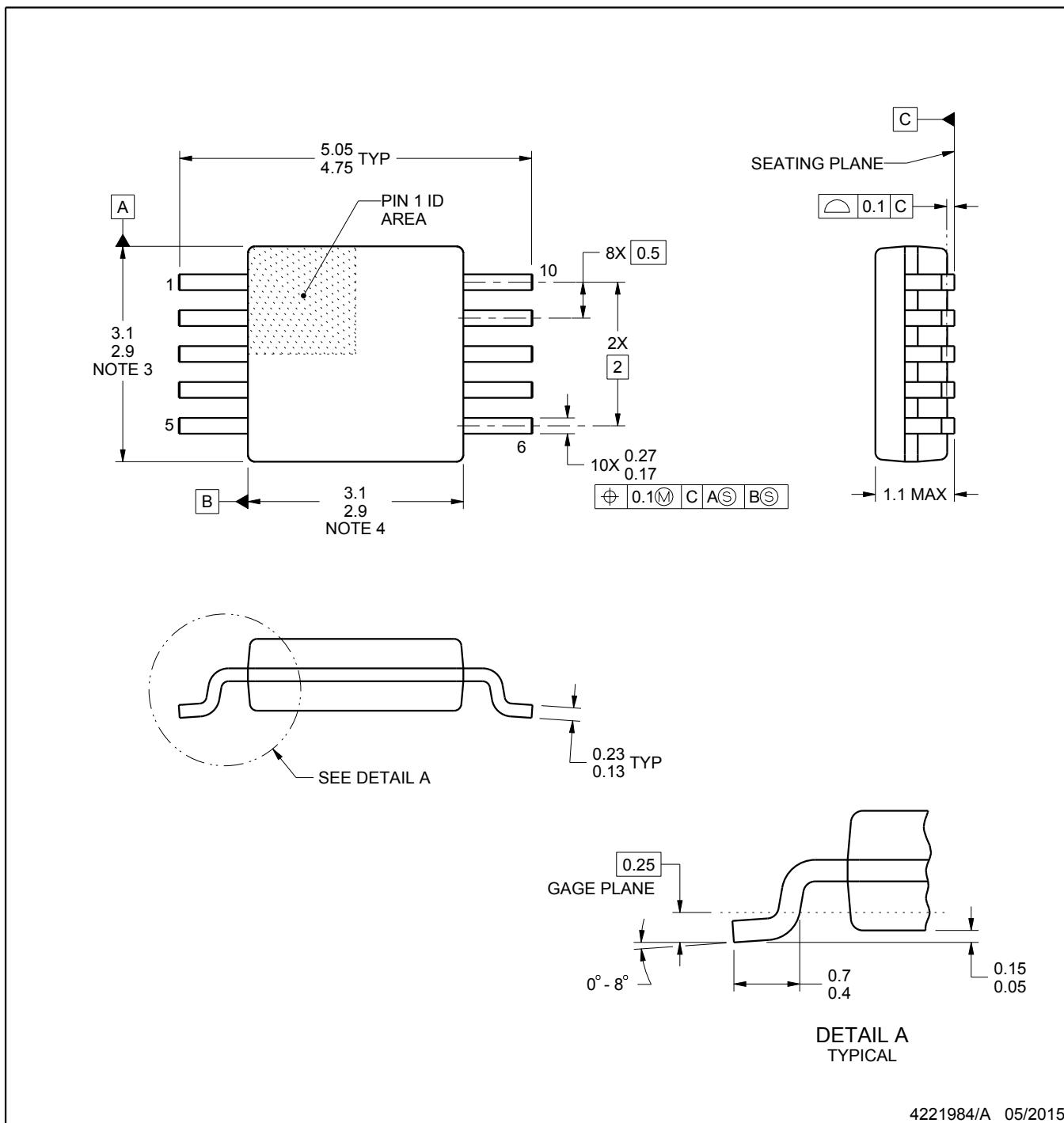
PACKAGE OUTLINE

DGS0010A



VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

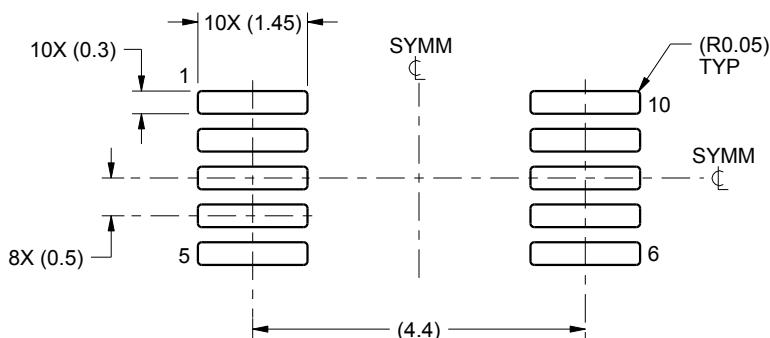
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187, variation BA.

EXAMPLE BOARD LAYOUT

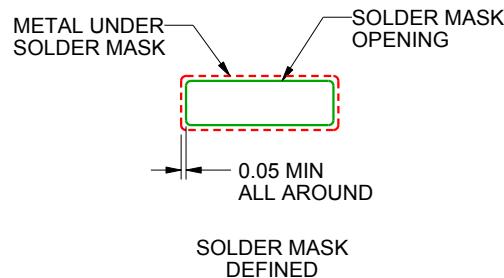
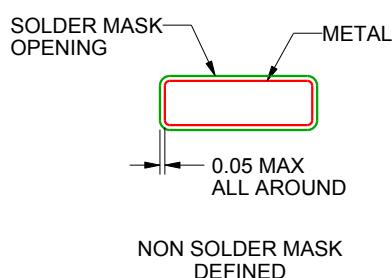
DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
SCALE:10X



SOLDER MASK DETAILS
NOT TO SCALE

4221984/A 05/2015

NOTES: (continued)

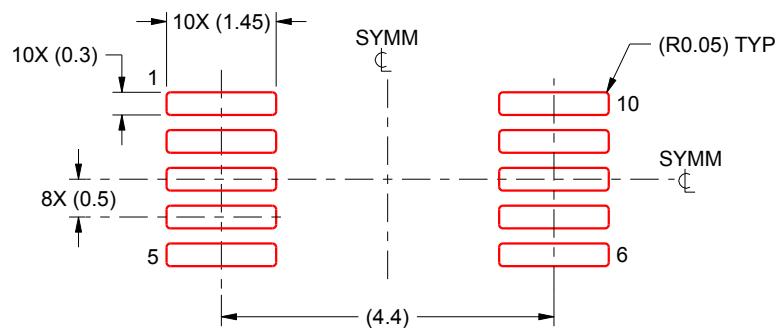
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:10X

4221984/A 05/2015

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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